

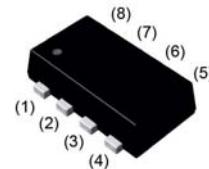
V_{DSS}	30V
$R_{DS(on)}$ (Max.)	90m Ω
I_D	$\pm 2.5A$
P_D	1.25W

●Features

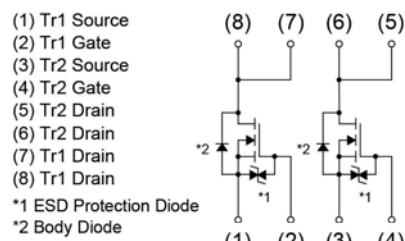
- 1) Low on - resistance.
- 2) Built-in G-S protection diode.
- 3) Small surface mount package(TSST8)
- 4) 2.5V drive
- 5) Pb-free lead plating ; RoHS compliant

●Outline

TSST8



●Inner circuit



●Packaging specifications

Type	Packing	Embossed Tape
	Reel size (mm)	180
	Tape width (mm)	8
	Basic ordering unit (pcs)	3000
	Taping code	TR
	Marking	K02

●Absolute maximum ratings ($T_a = 25^\circ C$) <It is the same ratings for the Tr1 and Tr2>

Parameter	Symbol	Value	Unit
Drain - Source voltage	V_{DSS}	30	V
Continuous drain current	I_D	± 2.5	A
Pulsed drain current	$I_{D,pulse}^{*1}$	± 10	A
Gate - Source voltage	V_{GSS}	± 12	V
Power dissipation	total	P_D^{*2}	1.25
	element		1.0
	total	P_D^{*3}	0.6
Junction temperature	T_j	150	°C
Range of storage temperature	T_{stg}	-55 to +150	°C

● Thermal resistance

Parameter	Symbol	Values			Unit
		Min.	Typ.	Max.	
Thermal resistance, junction - ambient	total	R_{thJA}^{*2}	-	-	100
	element		-	-	125
	total	R_{thJA}^{*3}	-	-	208

● Electrical characteristics ($T_a = 25^\circ\text{C}$) <It is the same characteristics for the Tr1 and Tr2>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Drain - Source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{V}, I_D = 1\text{mA}$	30	-	-	V
Breakdown voltage temperature coefficient	$\frac{\Delta V_{(BR)DSS}}{\Delta T_j}$	$I_D = 1\text{mA}$ referenced to 25°C	-	29	-	$\text{mV}/^\circ\text{C}$
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 30\text{V}, V_{GS} = 0\text{V}$	-	-	1	μA
Gate - Source leakage current	I_{GSS}	$V_{DS} = 0\text{V}, V_{GS} = \pm 12\text{V}$	-	-	± 10	μA
Gate threshold voltage	$V_{GS(\text{th})}$	$V_{DS} = 10\text{V}, I_D = 1\text{mA}$	0.5	-	1.5	V
Gate threshold voltage temperature coefficient	$\frac{\Delta V_{GS(\text{th})}}{\Delta T_j}$	$I_D = 1\text{mA}$ referenced to 25°C	-	-1.6	-	$\text{mV}/^\circ\text{C}$
Static drain - source on - state resistance	$R_{DS(\text{on})}^{*4}$	$V_{GS} = 4.5\text{V}, I_D = 2.5\text{A}$	-	65	90	$\text{m}\Omega$
		$V_{GS} = 4\text{V}, I_D = 2.5\text{A}$	-	70	95	
		$V_{GS} = 2.5\text{V}, I_D = 2.5\text{A}$	-	95	130	
Gate input resistance	R_G	$f = 1\text{MHz}, \text{open drain}$	-	20	-	Ω
Forward Transfer Admittance	$ Y_{fs} ^{*4}$	$V_{DS} = 10\text{V}, I_D = 2.5\text{A}$	2.2	-	-	S

●Electrical characteristics ($T_a = 25^\circ\text{C}$) <It is the same characteristics for the Tr1 and Tr2>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Input capacitance	C_{iss}	$V_{GS} = 0\text{V}$ $V_{DS} = 10\text{V}$ $f = 1\text{MHz}$	-	180	-	pF
Output capacitance	C_{oss}		-	60	-	
Reverse transfer capacitance	C_{rss}		-	35	-	
Turn - on delay time	$t_{d(on)}^{\ast 4}$	$V_{DD} \approx 15\text{V}, V_{GS} = 4.5\text{V}$ $I_D = 1.2\text{A}$ $R_L = 12.5\Omega$ $R_G = 10\Omega$	-	7	-	ns
Rise time	$t_r^{\ast 4}$		-	30	-	
Turn - off delay time	$t_{d(off)}^{\ast 4}$		-	20	-	
Fall time	$t_f^{\ast 4}$		-	20	-	

●Gate charge characteristics ($T_a = 25^\circ\text{C}$) <It is the same characteristics for the Tr1 and Tr2>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Total gate charge	$Q_g^{\ast 4}$	$V_{DD} \approx 15\text{V}$ $I_D = 2.5\text{A}$ $V_{GS} = 4.5\text{V}$	-	3.2	-	nC
Gate - Source charge	$Q_{gs}^{\ast 4}$		-	0.9	-	
Gate - Drain charge	$Q_{gd}^{\ast 4}$		-	0.4	-	

●Body diode electrical characteristics (Source-Drain) ($T_a = 25^\circ\text{C}$)

<It is the same characteristics for the Tr1 and Tr2>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Body diode continuous forward current	I_S	$T_a = 25^\circ\text{C}$	-	-	0.8	A
Body diode pulse current	$I_{SP}^{\ast 1}$		-	-	10	
Forward voltage	$V_{SD}^{\ast 4}$	$V_{GS} = 0\text{V}, I_S = 2.5\text{A}$	-	-	1.2	V

*1 $P_w \leq 10\mu\text{s}$, Duty cycle $\leq 1\%$

*2 Mounted on a ceramic board (30×30×0.8mm)

*3 Mounted on a FR4 (20×20×0.8mm)

*4 Pulsed

● Electrical characteristic curves

Fig.1 Power Dissipation Derating Curve

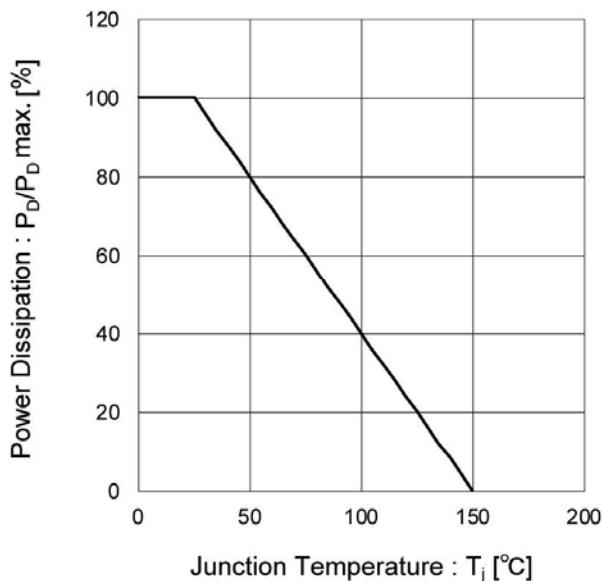


Fig.2 Maximum Safe Operating Area

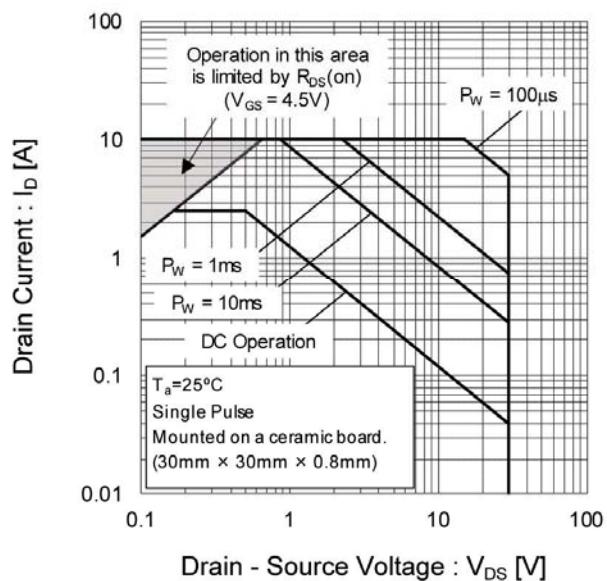


Fig.3 Normalized Transient Thermal Resistance vs. Pulse Width

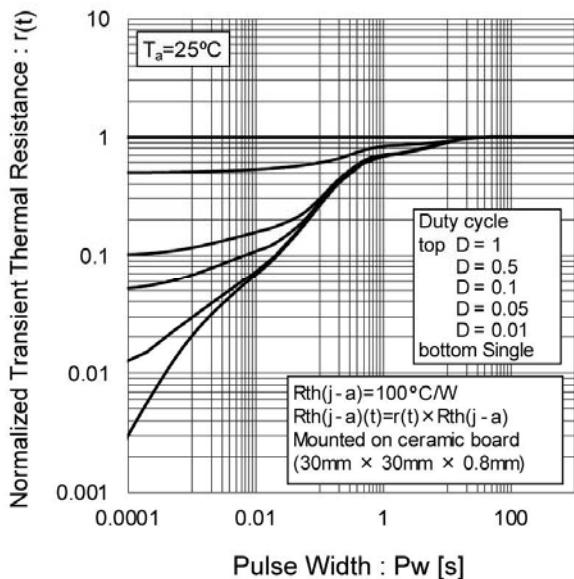
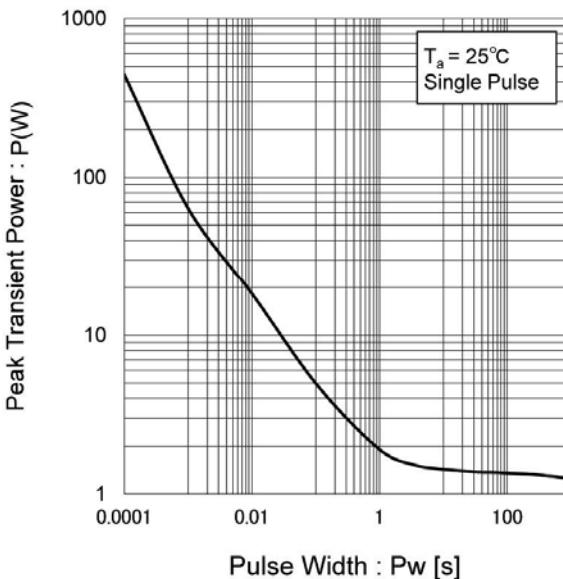


Fig.4 Single Pulse Maximum Power dissipation



● Electrical characteristic curves

Fig.5 Typical Output Characteristics(I)

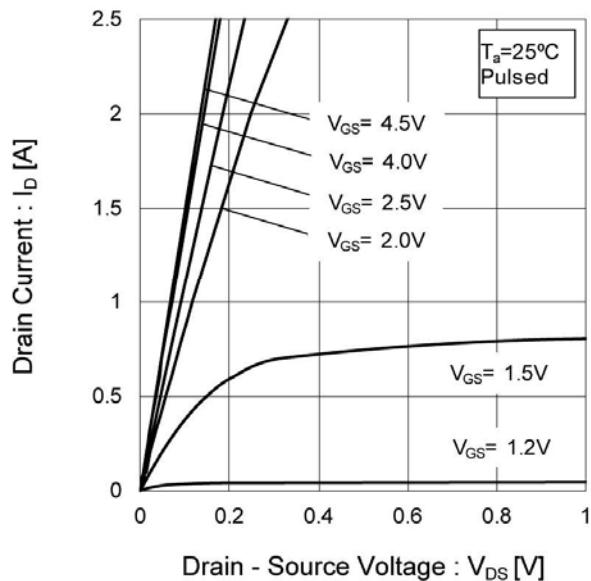


Fig.6 Typical Output Characteristics(II)

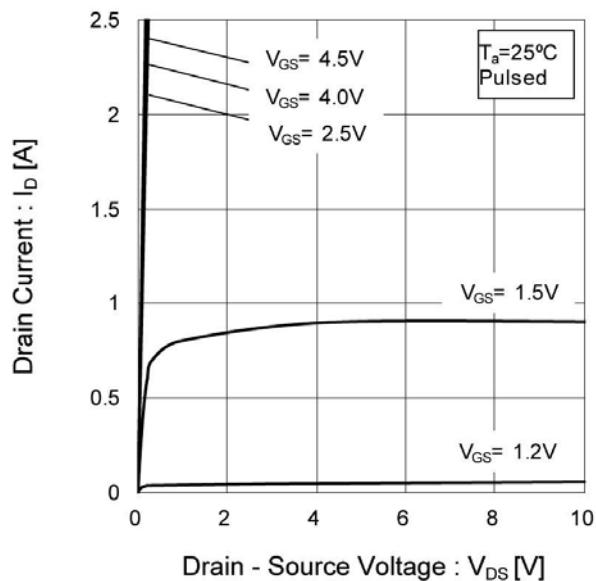


Fig.7 Breakdown Voltage vs.
Junction Temperature

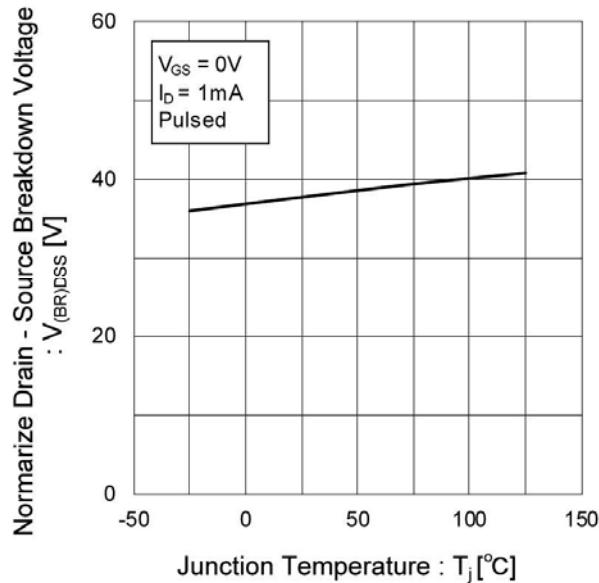
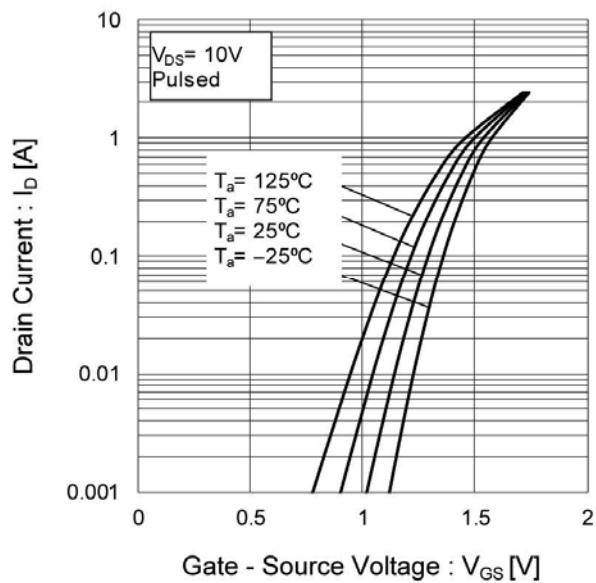


Fig.8 Typical Transfer Characteristics



●Electrical characteristic curves

Fig.9 Gate Threshold Voltage vs.
Junction Temperature

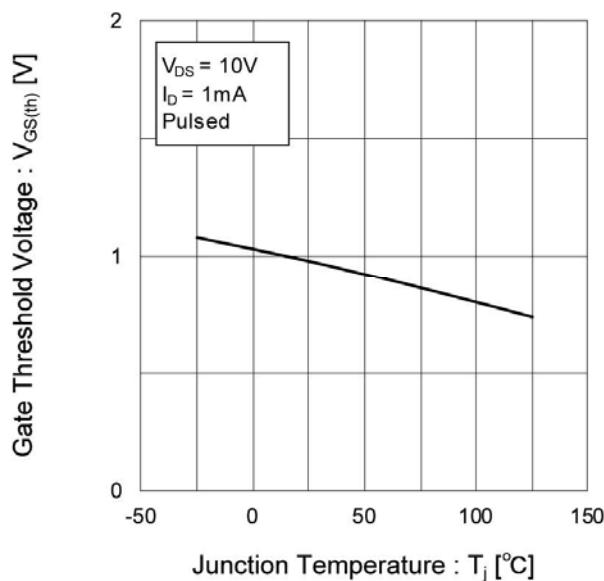


Fig.10 Forward Transfer Admittance vs.
Drain Current

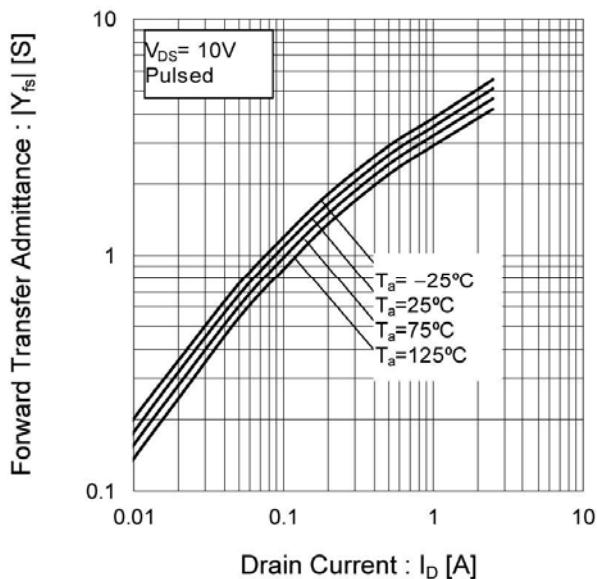


Fig.11 Drain Current Derating Curve

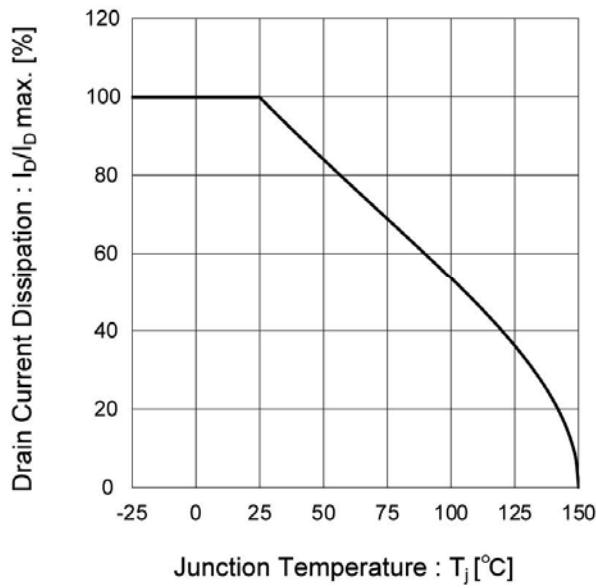
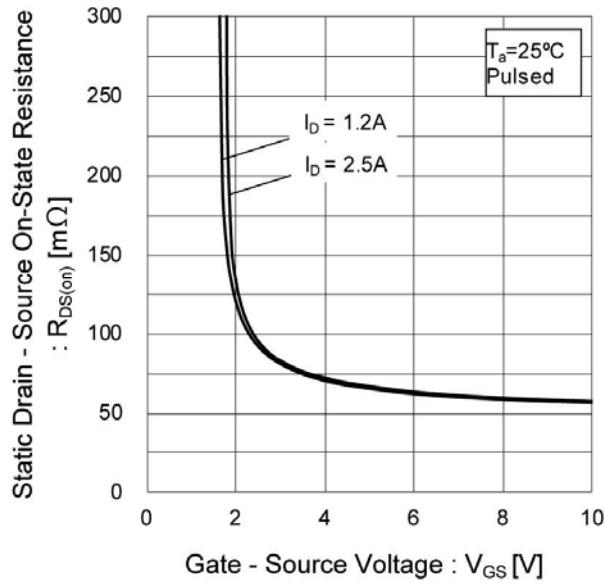


Fig.12 Static Drain - Source On - State
Resistance vs. Gate Source Voltage



●Electrical characteristic curves

Fig.13 Static Drain - Source On - State
Resistance vs. Junction Temperature

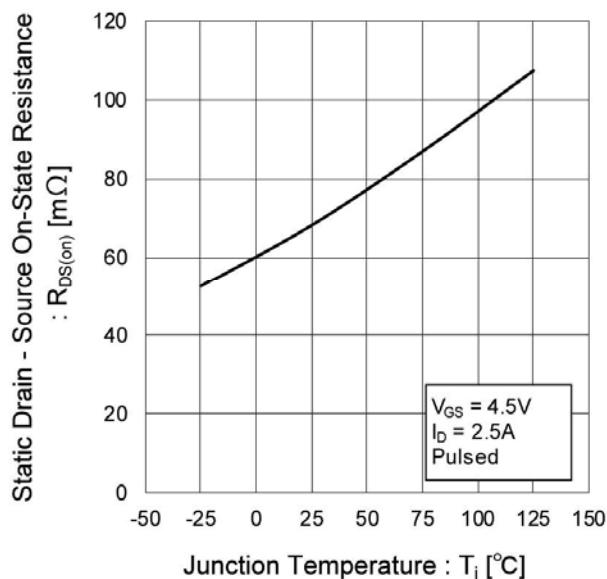
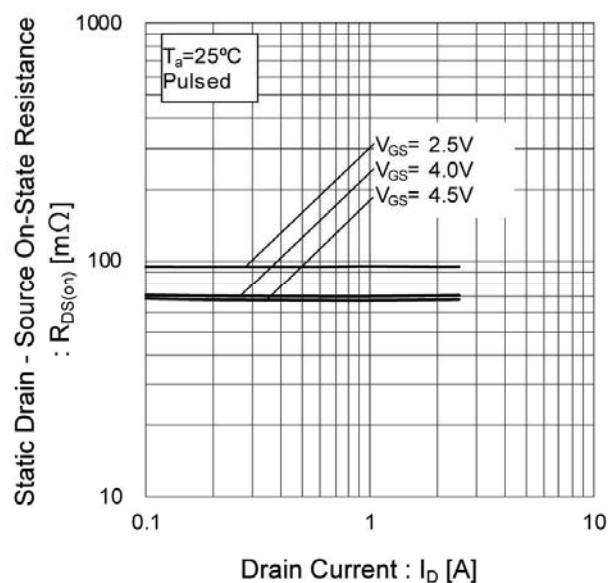


Fig.14 Static Drain - Source On - State
Resistance vs. Drain Current(I_D)



●Electrical characteristic curves

Fig.15 Static Drain - Source On - State
Resistance vs. Drain Current(I_D)

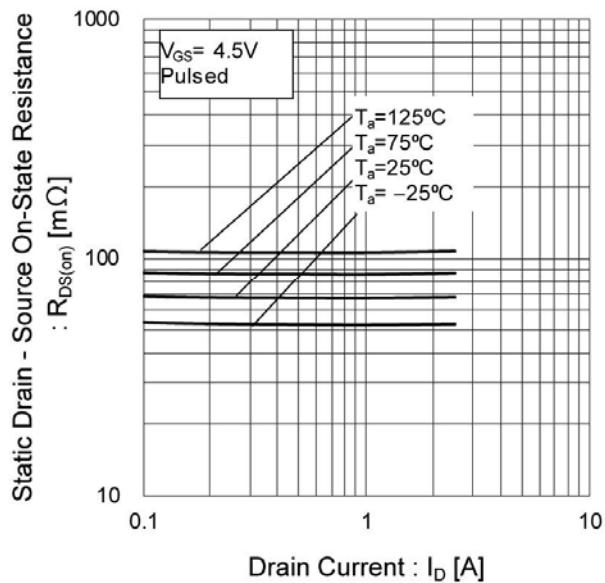


Fig.16 Static Drain - Source On - State
Resistance vs. Drain Current(I_D)

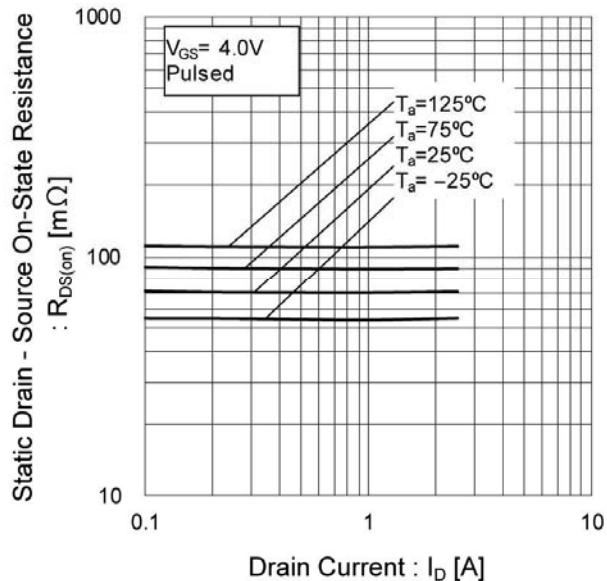
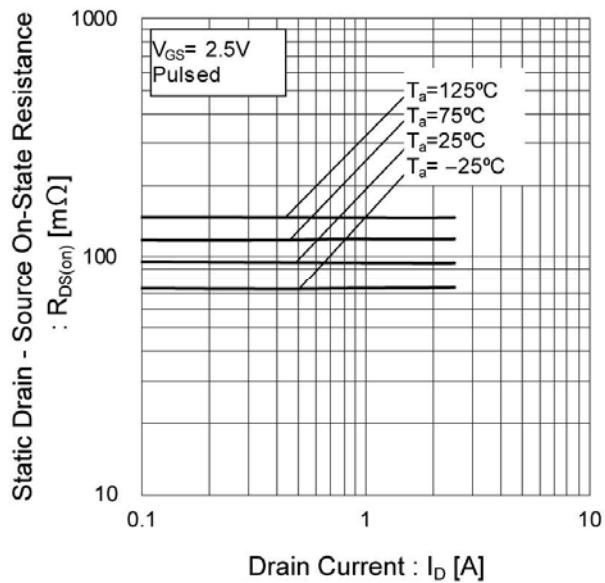


Fig.17 Static Drain - Source On - State
Resistance vs. Drain Current(I_D)



●Electrical characteristic curves

Fig.18 Typical Capacitance vs.
Drain - Source Voltage

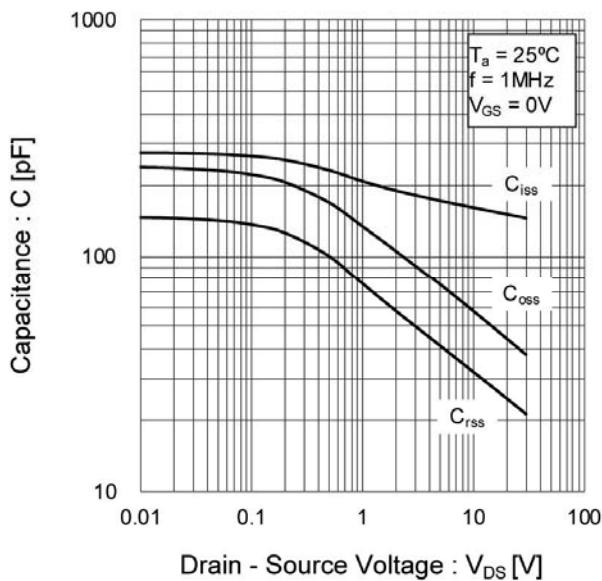


Fig.19 Switching Characteristics

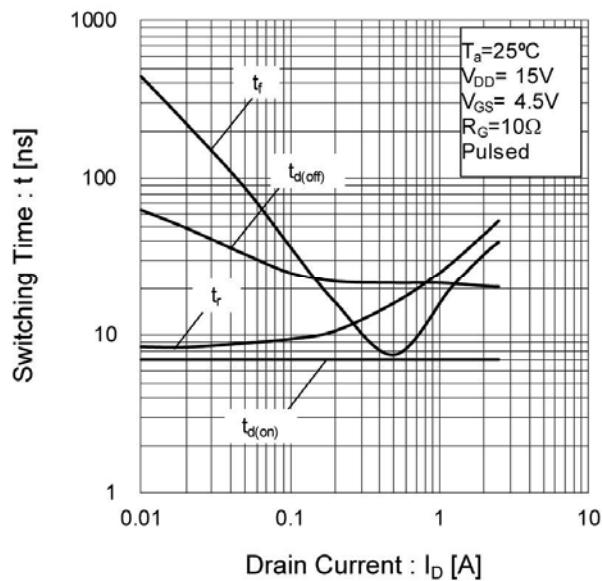


Fig.20 Dynamic Input Characteristics

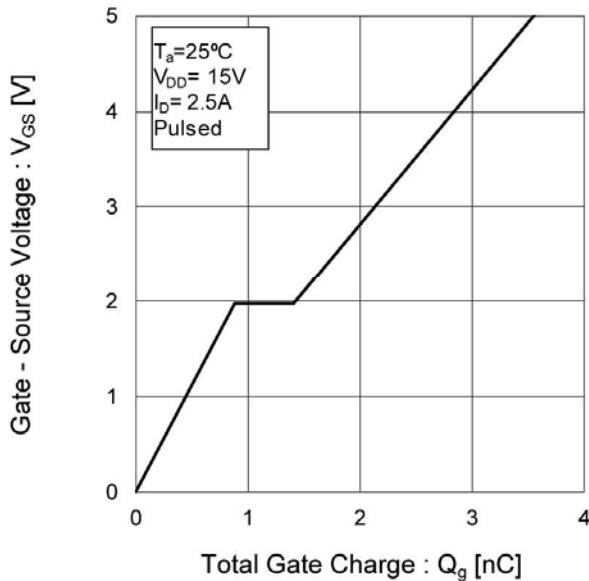
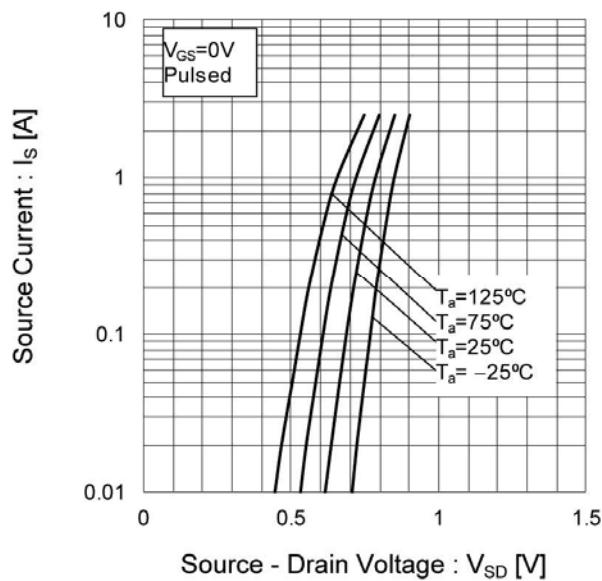


Fig.21 Source Current vs.
Source Drain Voltage



● **Measurement circuits** <It is the same for the Tr1 and Tr2>

Fig. 1-1 SWITCHING TIME MEASUREMENT CIRCUIT

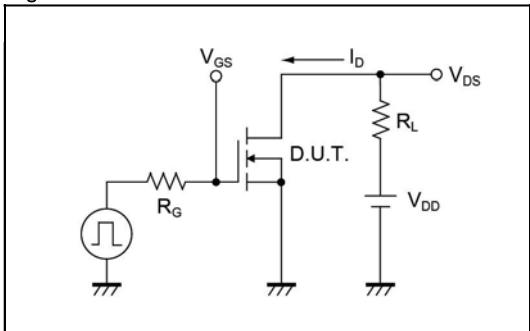


Fig. 1-2 SWITCHING WAVEFORMS

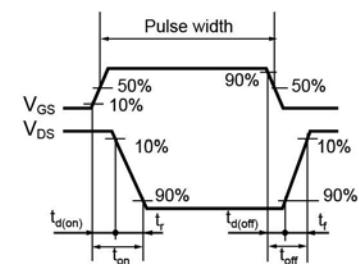


Fig. 2-1 GATE CHARGE MEASUREMENT CIRCUIT

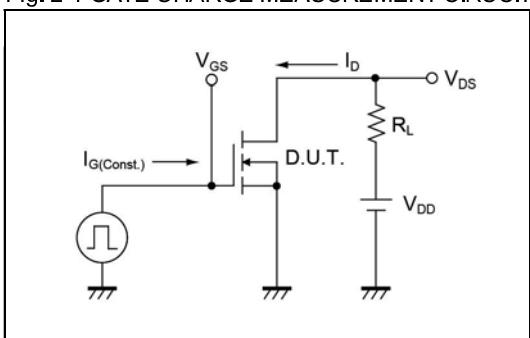
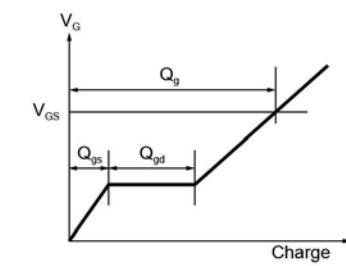
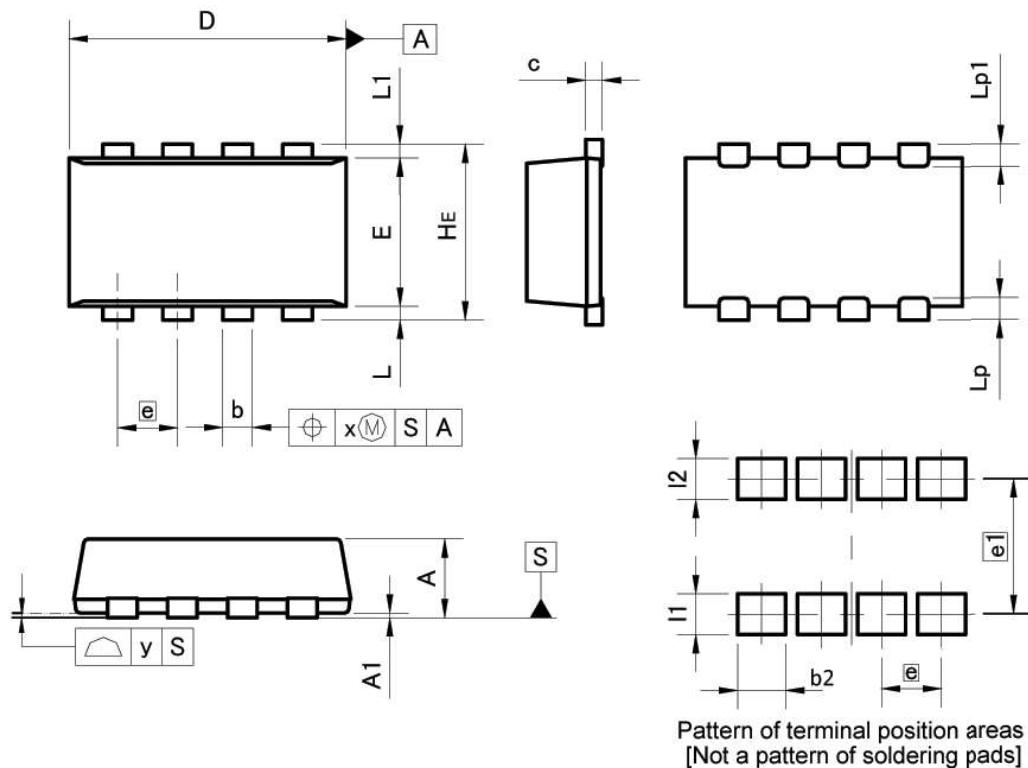


Fig. 2-2 GATE CHARGE WAVEFORM



●Dimensions

TSST8



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.75	0.85	0.030	0.033
A1	0.00	0.05	0.000	0.002
b	0.22	0.42	0.009	0.017
c	0.12	0.22	0.005	0.009
D	2.90	3.10	0.114	0.122
E	1.50	1.70	0.059	0.067
e	0.65		0.026	
H_E	1.80	2.00	0.071	0.079
L	0.05	0.25	0.002	0.010
L1	0.05	0.25	0.002	0.010
Lp	0.15	0.34	0.006	0.013
Lp1	0.15	0.34	0.006	0.013
x	—	0.10	—	0.004
y	—	0.10	—	0.004

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
b2	—	0.52	—	0.020
e1	1.46		0.057	
I1	—	0.44	—	0.017
I2	—	0.44	—	0.017

Dimension in mm/inches

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